PTO/SB/08A (08-03) Complete if Known itule for form 1449A/PTO Application Number 10/644,644 INFORMATION DISCLOSURE August 19, 2003 Filing Date First Named Inventor STATEMENT BY APPLICANT Henley, François J. Not Yet Assigned. 282] Art Unit Not Yet Assigned (use as many sheets as necessary) **Examiner Name**

Sheet

of

Attorney Docket Number

018419-000183US

			0.3. FF	TENT DOCUMENTS+	
zaminer Initials*	Cite No.1	Document Number Number Kind Code ³ (if known)	Publication Data MM-00-YYYY	Name of Potenties or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
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1	3	3,225,820	12/1995	Riordan	
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\top	6	3,770,499	10/1973	Crowe et al.	
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+	19	4,074,139	02/1978	Pankove	. /
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\top	22	4,116,751	09/1978	Zaromb	
十	23	4,121,334	10/1978	Wallis	· /
ŀ	24	4,170,662	10/1979	Weiss et al.	
	25	4,216,906	08/1980	Olsen et al	
T	26	4,237,601	12/1980	Woolhouse et al.	
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7	28	4,252,837	02/1981	Auton	
Tu	29	4,255,208	03/1981	Deutscher et al.	

EXAMINER: Initial if reference considered, whether/or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered, include copy of this form with next communication to applicant. Applicant's unique citation designation number (optional). Kind Codes of U.S. Petent Occuments at www.usrio.cov or MPEP 801.04. Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). For Japanese patent documents, the indication of the year of the Emperor must precede the serial number of the patent document. Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST. 16 if possible. Applicant is to place a check mark here if English language Translation is attached.

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INFORMATION DISCLOSURE STATEMENT BY APPLICANT

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of 12

	
	Complete if Known
Application Number	10/644,644
Filing Date	August 19, 2003
First Named Inventor	Henley, François J.
Art Unit	Not Yet Assigned > 2
Examiner Name	Not Yet Assigned H. LEE
Attorney Docket Number	018419-000183US

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Examiner Initials'	Cita No.1	Number Kind Code [®] (# known)	Publication Data MOJ-DD-YYYY	Name of Patentise or * Applicant of Cited Document	Pegss, Columns, Lines, Where Relevant Pessages or Relevant Figures Appear
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$\neg \tau$	43	4,508,056	04/1985	Bruel et al.	7
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	45	4,539,050	09/1985	Kramler et al.	· /
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γ	58	4,837,172	06/1989	Mizzno et al.	

EXAMINER: trifial if reference considered, whether or not cliation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered, include copy of this form with next communication to applicant. Applicant's unique citation designation number (epitenal). Kind Codes of U.S. Patent Documents at www.usato.ogv or MPEP 801.04. Enter Office that issued the document, by the wo-letter code (WIPO Standard ST.3). For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST. 16 if possible. Applicant is to place a check mark here if English language Translation is attached.

·PTO/SB/08A (08-03) titute for form 1449A/PTO Complete if Known **Application Number** 10/644,644 INFORMATION DISCLOSURE August 19, 2003 Filing Date STATEMENT BY APPLICANT First Named Inventor Henley, Francois J. Art Unit Not Yet Assigned 2823 (use as many sheets as necessary)

Sheet

Examiner Name

Attorney Docket Number

Not Yet Assigned 018419-000183US

			U.S. PA	TENT DOCUMENTS	
xeminer Initiats*	Cito No.1	Document Number Humber Kind Code [®] (# known)	Publication Data NM-DD-YYYY	Name of Patentee or, Applicant of Cited Document	Pagas, Columns, Lines, Where Referant Passages or Relevant
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+	62	4,883,561	11//1989	Gmitter et al.	<i></i>
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	77	5,082,793	01/1992	Li	/
	78	5,102,821	04/1992	Moslehi	//
	79	5,110,748	05/1992	Sarma	
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"EXAMINER: Initial if reference considered, whether or not cliation to in conformance with MPEP 609. Draw line through citation if not in conformance and not considered, include copy of his form with heat communication to applicant. Applicant's unique citation designation number (optional). Vind Codes of U.S. Patent Documents at www.usbio.org/nemper-901.04. Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. It fund of document by the appropriate symbols as indicated on the document under WIPO Standard ST. 18 if possible. Applicant is to place a check mark here if English language Translation is attached.

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INFORMATION DISCLOSURE STATEMENT BY APPLICANT

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Sheet 4 of 12

	Complete If Known
Application Number	10/644,644
Filing Date	August 19, 2003
First Named Inventor	Henley, Francois J.
Art Unit	Not Yet Assigned 227
Examiner Name	Not Yet Assigned H LEE
Attorney Docket Number	018419-000183US

			U.S. P/	TENT DOCUMENTS	•
		Occument Number			
Examiner initiats	Cita No.1	Number Kind Code ² (# known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pagas, Columna, Lines, Where Relevant Passagos or Relevant Figures Appear
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	97	5,273,610	12/1993	Thomas, III et al.	/
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	101	5,308,776	05/1994	Gotou	
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	106	5,362,671	11/1994	Zavracky et al.	/ .
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\prod	113	5,404,079	04/1995	Ohkuni et al.	/
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6	115	5,411,592	05/1995	Ovshinsky et al.	/
M	H6	5,413,679	05/1995	Godbey	/
Examine Signatur		Kin M	in Lu	Oate Considered	5/2/5-

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PTO/SB/08A (08-03) C mplete if Known tute for form 1448A/PTO **Application Number** 10/644,644 INFORMATION DISCLOSURE Filing Date August 19, 2003 STATEMENT BY APPLICANT First Named Inventor Henley, Francois J. **Art Unit** Not Yet Assigned (use as many sheets és necessary) **Examiner Name** Net-Yet-Accigned 018419-000183US Sheet of **Attorney Docket Number**

		·	U.S. PA	TENT DOCUMENTS	<u> </u>
Suminer Initials*	Cite No.1	Document Number Number Kind Code ⁸ (# known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Unes, Where Relevant Passages or Relevant Figures Appear
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*7	118	5,438,241	08/1995	Zavracky et al.	· /
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	131	5,559,043 .	09/1996	Bruel	/ .
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Þ	144	5,763,319	06/1998	Ling et al.	/
/JI	145	5,783,022	07/1998	Cha et al.	· .

"EXAMINER: tritial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered, include copy of this form with next communication to applicant. Applicant's unique citation designation number (optional). Kind Codes of U.S. Patent Documents at www.ussto.gov or MPEP 901.04. Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). For Japanesse patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. Nind of document by the appropriate symbols as indicated on the document under WIPO Standard ST. 18 if possible. Applicant is to place a check mark here if English tanguage Translation is attached.

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INFORMATION DISCLOSURE STATEMENT BY APPLICANT

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Sheet 6 of 12

	Complete if Known
Application Number	10/644,644
Filing Date	August 19, 2003
First Named Inventor	Henley, François J.
Art Unit	Not Yet Assigned 262]
Examiner Name	Not Yet Assigned H LEE-
Attorney Docket Number	018419-000183US

			U.S. P/	TENT DOCUMENTS	<u> </u>
Examiner		Document Number	Publication Date	Name of Patentee or	Pages, Columns, Unos, Where
trillats*	Cite No.	Number Kind Code ² (# known)	MIM-DD-YYYY	Applicant of Clied Document	Relevant Pessages or Relevant Figures Appear
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Examiner Signature	Rs	COST	Min	Lu	Date Considered	6/2/	
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PTO/SB/08A (08-03) te for form 1449A/PTO Complete if Known 10/644,644 **Application Number INFORMATION DISCLOSURE** Filing Date August 19, 2003 STATEMENT BY APPLICANT First Named Inventor Henley, Francois J. Art Unit **Not Yet Assigned** 282 (use as many sheets as necessary) **Examiner Name** Not Yet Assigned 018419-000183US of 12 **Attorney Docket Number**

		·	U.S. P/	ATENT DOCUMENTS+	
		Document Number			
Examiner tritials*	Cita No.1	Number Kind Cods ² (# known)	Publication Date MIM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pagss, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
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Examin	Cite	1	Foreign Patent Do	current	Publication	Name of Patentee or	Pages, Columns, Lines, Where Relevant Passages	
Initials	No.1	Country Code ³	Number ⁴	Kind Code ^s (If known)	Date MM-DD- YYYY	Applicant of Cited Document	or Relevant Figures Appear	T
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Examiner Signature	Keren	Min	Lu	Date Considered	6/2/5

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INFORMATION DISCLOSURE STATEMENT BY APPLICANT

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Sheet 8 of 12

Complete if Known						
Application Number	10/644,644					
Filing Date	August 19, 2003					
First Named Inventor	Henley, François J.					
Art Unit	Not Yet Assigned > \$25					
Examiner Name	Not Yet Assigned H. LEG					
Attorney Docket Number	018419-000183US					

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INFORMATION DISCLOSURE STATEMENT BY APPLICANT

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Sheet 9 of 12

	Complete if Known
Application Number	10/644,644
Filing Date	August 19, 2003
First Named Inventor	Henley, François J.
Art Unit	Not Yet Assigned 2827
Examiner Name	Not Yet Assigned H LEE
Attorney Docket Number	018419-000183US

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August 19, 2003

Henley, François J.

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INFORMATION DISCLOSURE
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Application Number
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First Named Inventor
Art Unit
Examiner Name

of 12

		NON PATENT LITERATURE DOCUMENTS	
Examiner Initials *	Cite No.1	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	τ
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ita for form 1449B/PTO C mplete if Known Application Number 10/644,644 MFORMATION DISCLOSURE · Filing Date August 19, 2003 STATEMENT BY APPLICANT First Named Inventor Henley, Francois J. Art Unit Not Yet Assigned (use as many sheets as necessary) Examiner Name Not-Yet Assigned Sheet of 12 Attorney Docket Number 018419-000183US

		NON PATENT LITERATURE DOCUMENTS		1
Examiner Initials •	Cite No.1	Include name of the author (in CAPITAL LETTERS), title of the srticle (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T2	
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